Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/552,811	BAIER ET AL.
Examiner	Art Unit
Hana A. Sanei	2879

SEARCHED				
Class	Subclass	Date	Examiner	
313	637	8/31/2006	HAS	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY))
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